

Search Notes

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Examiner

Phu Vu

Applicant(s)/Patent under
Reexamination

YANO ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
349	118	4/10/2005	PV

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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